Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	10905	stray$4 near10 light$6	US-PGPUB; USPAT	OR	ON	2005/08/01 16:33
L2	1303	1 same(correction$3 or adjust$4 or enhanc$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:23
L3	152	2 same(color$3)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:24
L4	157	2 same(color$3 or colour$2)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L5	4	4 same(gray$4 or grey$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 17:53
L6	844	(stray$4 near10 light$6)and(colour$3 or color$3)and(gray$3 or grey$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:25
L7	781	6 and(correct$6 or adjust$6 or enhanc$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:27
L8	44	7 and(solid$6 near10 array$3)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:28
L9	44	8 and(calculat$6 or multipl$3 or comput$6 or sabtract$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L10	10	9 and(bright$6 near10(compar$6 or correlat$6 or match$4))	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L11	47782	((stray$4 or reflect$6) near10 light$6)same(correction$3 or adjust$6 or enhanc$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L12	6981	11 same(color$3 or colour$2)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L13	273	12 same(gray$4 or grey$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L14	204	13 and(calculat$6 or multipl$3 or comput$6 or sabtract$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L15	27	14 and(bright$6 near10(compar$6 or correlat$6 or match$4))	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L16	1	"6396217".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L17	1	"6297859".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L18	1	"5760843".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L19	1	"5760843".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L20	1	"5287173".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L21	1	"6489601".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54

L22	1	"6301019".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54
L23	1	"6229627".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54

Search Result - Print Format

Key: IEEE JNL = IEEE Journal or Magazine, IEE JNL = IEE Journal or Magazine, IEEE CNF = IEEE Conference, IE CNF = IEE Conference, IEEE STD = IEEE Standard

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